AMENDMENTS TO THE CLAIMS

Please amend the claims as indicated below:

- 2 equipment using a multilayer circuit board on which a
- 3 semiconductor chip is mounted, comprising:
- 4 a thin film capacitor provided on said multilayer
- 5 circuit board, wherein a first electrode of said thin film
- 6 capacitor and a first wiring of said multilayer circuit
- 7 board, which wiring is formed of a metal different from a
- 8 metal of said first electrode, are electrically connected
- 9 to each other, a second electrode of said thin film
- 10 capacitor and a second wiring of said multilayer circuit
- 11 board being electrically connected to each other, and a
- 12 thin film dielectric of said thin film capacitor is formed
- 13 by being grown epitaxially with said first electrode as its
- 14 base.
- 1 2. (Original) The electronic circuit equipment using
- 2 said multilayer circuit board as claimed in Claim 1,
- 3 wherein said multilayer circuit board includes a resin and
- 4 a conductor, said thin film capacitor is buried in said
- 5 resin, and at least one of electrical connections between

- 6 said wirings and said electrodes is established via a hole
- 7 bored in said resin.
- 3. (Currently amended) The electronic circuit
- 2 equipment using said multilayer circuit board as claimed in
- 3 Claim 1, wherein said first electrode and said first wiring
- 4 are formed of materials different from each other, and have
- 5 the same pattern, and are laminated.
- 1 4. (Currently amended) An electronic circuit
- 2 equipment using a multilayer circuit board on which a
- 3 semiconductor chip is mounted, comprising:
- 4 a thin film capacitor provided on said multilayer
- 5 circuit board, wherein a first electrode of said thin film
- 6 capacitor and a first wiring of said multilayer circuit
- 7 board, which wiring is formed of a metal different from a
- 8 metal of said first electrode, are electrically connected
- 9 to each other, a second electrode of said thin film
- 10 capacitor and a second wiring of said multilayer circuit
- 11 board being electrically connected to each other, and a
- 12 thin film dielectric of said thin film capacitor is formed
- 13 by being grown epitaxially with said first electrode as its
- 14 base The electronic circuit equipment using said multilayer

- 15 circuit board as claimed in Claim 1, wherein an area of
- 16 said second electrode is narrower than an area of said thin
- 17 film dielectric, and said second electrode is located on an
- 18 inner side of said thin film dielectric.
- 5. (Original) The electronic circuit equipment using
- 2 said multilayer circuit board as claimed in Claim 1,
- 3 wherein, in order to prevent an electrical short-circuit
- 4 between said first electrode and said second electrode,
- 5 said electrodes are insulated from each other with a
- 6 material that is the same as a material of said thin film
- 7 dielectric.
- 1 6. (Original) The electronic circuit equipment using
- 2 said multilayer circuit board as claimed in Claim 1,
- 3 wherein said first electrode is a metal selected from a
- 4 group including Ru, Pt, and Pd.
- 1 7. (Original) The electronic circuit equipment using
- 2 said multilayer circuit board as claimed in Claim 6,
- 3 wherein said thin film dielectric is formed of strontium
- 4 titanate.

- 1 8. (Original) The electronic circuit equipment using
- 2 said multilayer circuit board as claimed in Claim 1,
- 3 wherein said first electrode has a first connection layer
- 4 positioned on a plane of said first electrode opposite to
- 5 said thin film dielectric and formed of a metal different
- 6 from a conductor of said first electrode, said first
- 7 connection layer being a metal selected from a group
- 8 including Cr, Mo, and Ti.
- 9. (Original) The electronic circuit equipment using
- 2 said multilayer circuit board as claimed in Claim 1,
- 3 wherein said second electrode has a second connection layer
- 4 positioned on a plane facing said thin film dielectric and
- 5 formed of a metal different from a conductor of said second
- 6 electrode, said second connection layer being a metal
- 7 selected from a group including Cr, Mo, and Ti.
- 1 10. (Currently amended) The electronic circuit
- 2 equipment using said multilayer circuit board as claimed in
- 3 Claim 1, wherein, one of said first electrode and said
- 4 second electrode, which faces an electrode that is
- 5 positioned nearer to a conductor of a transmission line

- 6 formed on said multilayer circuit board is set at a
- 7 grounding potential.
- 1 11. (New) A multi-layer electronic circuit board
- 2 having an embedded thin film capacitor comprising:
- 3 a first dielectric circuit board layer;
- 4 a first electrically conductive layer supported on
- 5 said first dielectric layer;
- an electrode layer supported on said first
- 7 electrically conductive layer, said electrode layer being a
- 8 metal and having a composition different from that of said
- 9 first electrically conductive layer;
- 10 an epitaxial dielectric layer supported on said
- 11 electrode layer;
- 12 a metallic connection layer overlying said epitaxial
- 13 dielectric layer and in contact therewith;
- 14 a second electrically conductive layer overlying and
- 15 in contact with said metallic connection layer; and
- 16 a second circuit board dielectric layer covering said
- 17 second electrically conductive layer.

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- 1 12. (New) The multi-layer electronic circuit board of
- 2 claim 11, wherein said metal of said electrode layer is
- 3 selected from the group consisting of Ru, Pt, and Pd.
- 1 13. (New) The multi-layer electronic circuit board of
- 2 claim 11, wherein said epitaxial dielectric layer is
- 3 strontium titanate..
- 1 14. (New) The multi-layer electronic circuit board of
- 2 claim 11, wherein said metallic connection layer is
- 3 selected formed from a metal selected from the group
- 4 consisting of Cr, Mo, and Ti.